Small Signal BJT and MOSFET

30 V, 500 mA, PNP BJT with 20 V, 224 mA, N-Channel MOSFET

Features

 These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

• Portable Devices

Q1 MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector–Emitter Voltage	V_{CEO}	30	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V _{EBO}	5.0	V
Collector Current	I _C	500	mA
Base Current	Ι _Β	50	mA

Q2 MAXIMUM RATINGS (T_J = 25°C unless otherwise specified)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	20	V
Gate-to-Source Voltage			V_{GS}	±8	٧
Continuous Drain	Steady	T _A = 25°C	I _D	224	mA
Current (Note 1)	State	T _A = 85°C		162	
	t ≤ 5 s	T _A = 25°C		241	
Pulsed Drain Current $T_p = 10 \mu s$		T _p = 10 μs	I _{DM}	673	mA
Source Current (Body Diode)			I _S	120	mA

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-to-Ambient (Note 1) Total Power Dissipation @ T _A = 25°C	R _{θJA} P _D	245 0.8	°C/W W
Operating Junction and Storage Temperature	T _J , T _{STG}	–55 to 150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on FR4 board using 1 in sq pad size (Cu. area = 1.127 in sq [1 oz] including traces).



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MARKING DIAGRAM



UDFN6 CASE 517AT μCOOL™



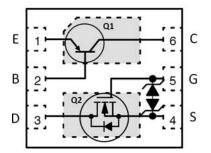
AE = Specific Device Code

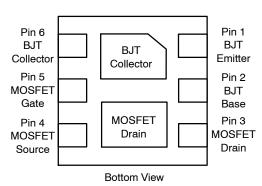
M = Date Code

■ = Pb-Free Package

(Note: Microdot may be in either location) *Date Code orientation may vary depending upon manufacturing location.

PIN CONNECTIONS





ORDERING INFORMATION

Device	Package	Shipping [†]
NSM3005NZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Test Condition

Min

Тур

Max

Unit

Q1 ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}\text{C}$ unless otherwise specified)

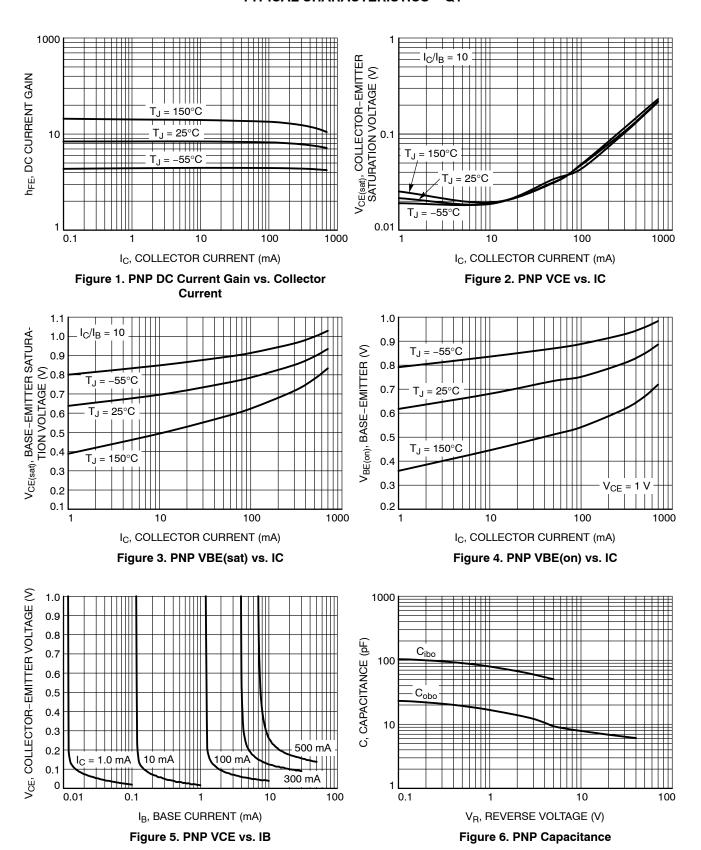
Symbol

Parameter

1 414	- ,			.,,,,		
OFF CHARACTERISTICS						
Collector-Base Breakdown Voltage	V _{(BR)CBO}	I _C = 100 μA	40	-	-	V
Collector–Emitter Breakdown Voltage	V _{(BR)CEO}	I _C = 10 mA	30	-	_	V
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	I _E = 100 μA	5.0	-	_	V
Collector Cutoff Current	I _{CBO}	V _{CB} = 25 V, I _E = 0 A	_	-	1.0	μΑ
Emitter Cutoff Current	I _{EBO}	V _{EB} = 5.0 V, I _C = 0 A	_	-	10	μΑ
ON CHARACTERISTICS (Note 2)		-				
DC Current Gain	h _{FE}	$V_{CE} = 3.0 \text{ V}, I_{C} = 30 \text{ mA}$	20	-	100	
		V _{CE} = 3.0 V, I _C = 100 mA	20	-	100	1
		V _{CE} = 3.0 V, I _C = 500 mA	20	-	100	1
Collector–Emitter Saturation Voltage	V _{CE(sat)}	I _C = 500 mA, I _B = 50 mA	-	-	0.4	V
Base–Emitter Saturation Voltage	V _{BE(sat)}	I _C = 500 mA, I _B = 50 mA	-	-	1.1	V
Base-Emitter Turn-On Voltage	V _{BE(on)}	V _{CE} = 1.0 V, I _C = 500 mA	_	-	1.0	V
				•	•	•
Q2 ELECTRICAL CHARACTERISTICS	$(T_J = 25^{\circ}C \text{ unle})$	ess otherwise specified)		•		
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = -250 μA, ref to 25°C	-	19	_	mV/°C
Zero Gate Votlage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 16 \text{ V}, T_J = 25^{\circ}\text{C}$	-	-	1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8.0 \text{ V}$	-	-	±2.0	μΑ
ON CHARACTERISTICS (Note 2)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$	0.4	-	1.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	-	-	1.9	-	mV/°C
Drain-to-Source On Resistance	R _{DS(ON)}	V _{GS} = 4.5 V, I _D = 100 mA	-	0.65	1.4	Ω
		$V_{GS} = 2.5 \text{ V}, I_D = 50 \text{ mA}$	-	0.9	1.9	
		$V_{GS} = 1.8 \text{ V}, I_D = 20 \text{ mA}$	_	1.1	2.2	
		$V_{GS} = 1.5 \text{ V}, I_D = 10 \text{ mA}$		1.4	4.3	
Forward Transconductance	9 _{FS}	$V_{DS} = 5.0 \text{ V}, I_{D} = 100 \text{ mA}$	-	0.56	-	S
CHARGES AND CAPACITANCES						
Input Capacitance	C _{ISS}	f = 1.0 MHz, V _{GS} = 0 V,	-	15.8	_	pF
Output Capacitance	C _{OSS}	V _{DS} = 15 V	-	3.5	_	
Reverse Transfer Capacitance	C _{RSS}		-	2.4	-	
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V};$	-	0.70	-	nC
Threshold Gate Charge	Q _{G(TH)}	I _D = 200 mA	-	0.05	-	
Gate-to-Source Charge	Q_{GS}		_	0.14	-	
Gate-to-Drain Charge	Q_{GD}		_	0.10	_	
SWITCHING CHARACTERISTICS, $V_{GS} = 4.5$	V (Note 3)					
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DD} = 15 \text{ V},$	-	18	-	ns
Rise Time	t _r	I_D = 200 mA, R_G = 2 Ω	-	35	-	
Turn-Off Delay Time	T _{d(ON)}		-	201	-	
Fall Time	t _f		-	110	_	
DRAIN-SOURCE DIODE CHARACTERISTIC	s					
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 10 \text{ mA}$	_	0.55	1.0	V
Pulsed Condition: Pulse Width - 300 msec						

Pulsed Condition: Pulse Width = 300 msec, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS - Q1



TYPICAL CHARACTERISTICS - Q2

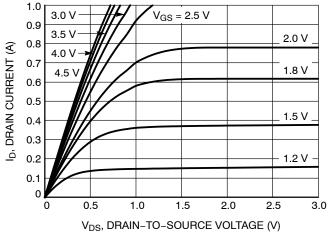


Figure 7. On-Region Characteristics

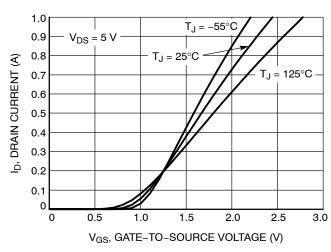


Figure 8. Transfer Characteristics

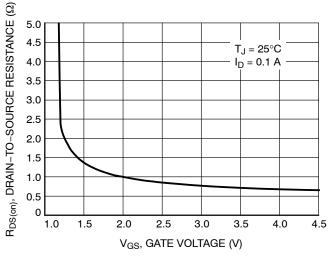


Figure 9. On-Resistance vs. Gate-to-Source Voltage

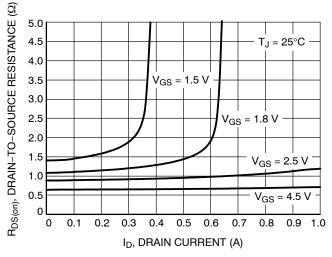


Figure 10. On-Resistance vs. Drain Current and Gate Voltage

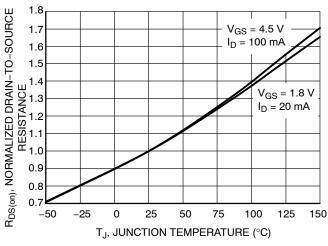


Figure 11. On–Resistance Variation with Temperature

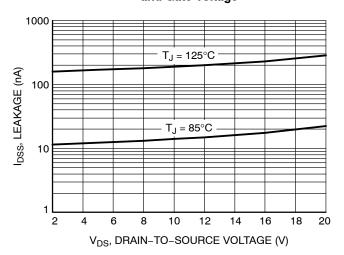


Figure 12. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS - Q2

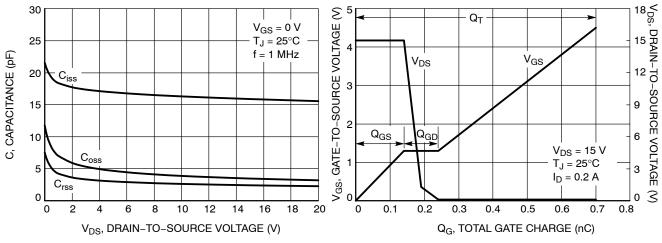


Figure 13. Capacitance Variation

Figure 14. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

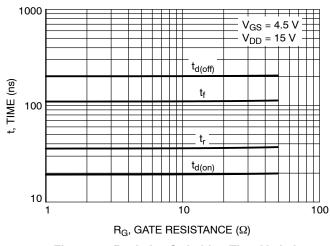


Figure 15. Resistive Switching Time Variation vs. Gate Resistance

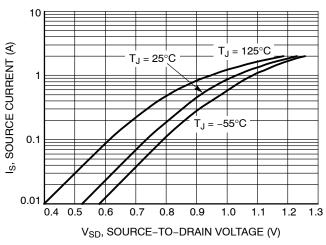


Figure 16. Diode Forward Voltage vs. Current

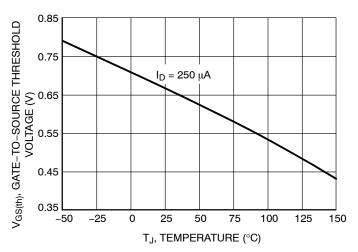
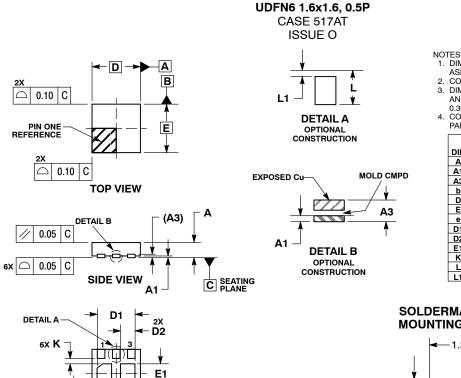


Figure 17. Threshold Voltage

PACKAGE DIMENSIONS



0.10

0.05

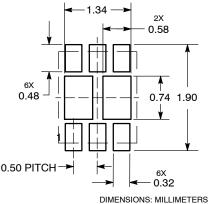
CAB

C NOTE 3

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND
- 0.30 mm FROM TERMINAL.
 COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.45	0.55		
A1	0.00	0.05		
А3	0.13 REF			
b	0.20 0.30			
D	1.60 BSC			
E	1.60 BSC			
е	0.50 BSC			
D1	1.14 1.34			
D2	0.38	0.58		
E1	0.54	0.74		
K	0.20			
L	0.15 0.35			
L1	0.10			

SOLDERMASK DEFINED MOUNTING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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